Search Notes		

Application/Cor	ntrol No.	Applicant(s)/Patent under Reexamination	
10/616,404		OSHIKAWA ET AL.	
Examiner		Art Unit	
Quana N. Vo		2625	

SEARCHED			
Class	Subclass	Date	Examiner
358	1.9	4/16/2007	QV
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	4/16/2007	QV
Inventor Name Search, see attachment	4/16/2007	QV
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